

<Intelligent Power Module>

## PM800DV1B060

FLAT-BASE TYPE INSULATED PACKAGE

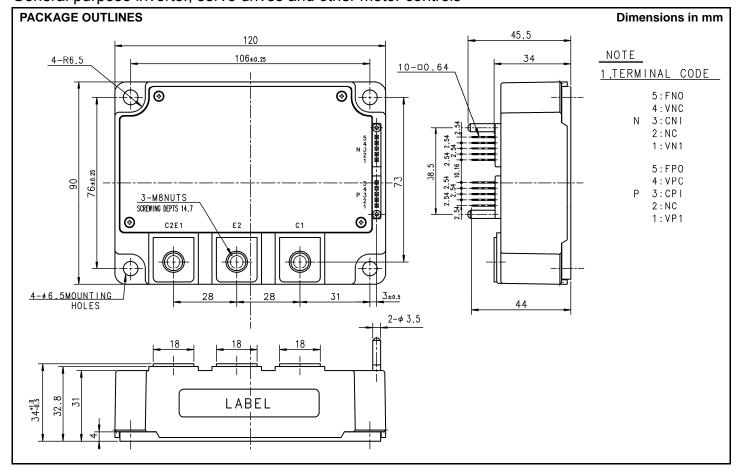


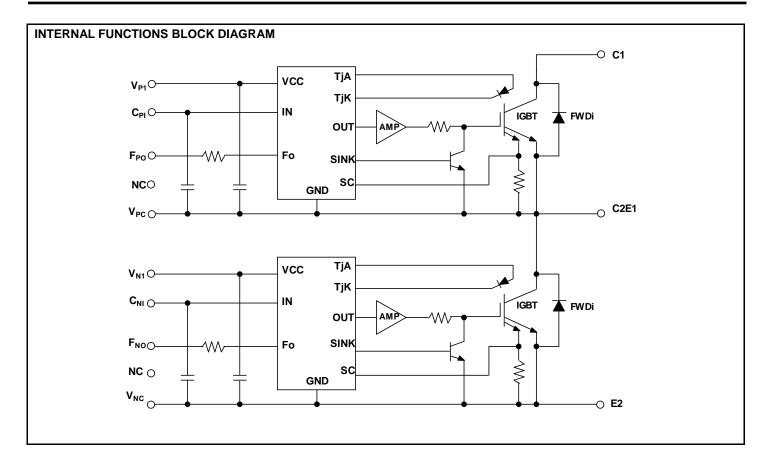
#### **FEATURE**

- a) Adopting new 5th generation Full-Gate CSTBT™ chip
- b) The over-temperature protection which detects the chip surface temperature of CSTBT™ is adopted.
- c) Error output signal is possible from all each protection upper and lower arm of IPM.
- d) Compatible V-series package.
- Monolithic gate drive & protection logic
- Detection, protection & status indication circuits for, short-circuit, over-temperature & under-voltage.

#### **APPLICATION**

General purpose inverter, servo drives and other motor controls





### **MAXIMUM RATINGS** ( $T_j = 25$ °C, unless otherwise noted)

#### **INVERTER PART**

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>CES</sub>	Collector-Emitter Voltage	V <sub>D</sub> =15V, V <sub>CIN</sub> =15V	600	V
I <sub>C</sub>	Collector Current	T <sub>C</sub> =25°C	800	Α
I <sub>CRM</sub>		Pulse	1600	
P <sub>tot</sub>	Total Power Dissipation	T <sub>C</sub> =25°C	2500	W
I <sub>E</sub>	Emitter Current	T <sub>C</sub> =25°C	800	Α
I <sub>ERM</sub>	(Free wheeling Diode Forward current)	Pulse	1600	
Tj	Junction Temperature		-20 ~ +150	°C

<sup>\*:</sup> Tc measurement point is just under the chip.

## **CONTROL PART**

Symbol	Parameter Conditions		Ratings	Unit
V <sub>D</sub>	Supply Voltage	Applied between : V <sub>P1</sub> -V <sub>PC</sub> , V <sub>N1</sub> -V <sub>NC</sub>	20	V
V <sub>CIN</sub>	Input Voltage	Applied between: C <sub>PI</sub> -V <sub>PC</sub> , C <sub>NI</sub> -V <sub>NC</sub>	20	V
V <sub>FO</sub>	Fault Output Supply Voltage	Applied between : F <sub>PO</sub> -V <sub>PC</sub> , F <sub>NO</sub> -V <sub>NC</sub>	20	٧
I <sub>FO</sub>	Fault Output Current	Sink current at F <sub>PO</sub> , F <sub>NO</sub> terminals	20	mA

#### **TOTAL SYSTEM**

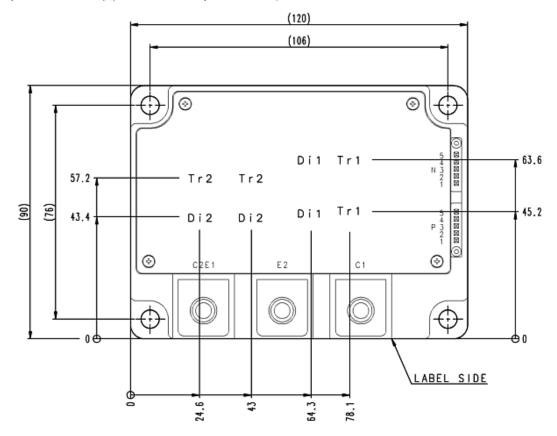
Symbol	Parameter	Conditions	Ratings	Unit
V	Supply Voltage Protected by	V <sub>D</sub> =13.5V ~ 16.5V	400	V
V <sub>CC(PROT)</sub>	SC	Inverter Part, T <sub>j</sub> =+125°C Start	400	V
V <sub>CC(surge)</sub>	Supply Voltage (Surge)	Applied between : C1-E2, Surge value	500	V
_	Module case operating		-20 ~ +100	°C
T <sub>C</sub>	temperature		-20 ~ +100	C
$T_{stg}$	Storage Temperature		-40 ~ +125	°C
V <sub>isol</sub>	loolation Valtage	60Hz,Sinusoidal, Charged part to Base plate,	2500	V
	Isolation Voltage	AC 1min, RMS	2500	V

 $<sup>\</sup>ensuremath{^*:}\ensuremath{\mathsf{T}_{C}}$  measurement point is just under the chip.

#### THERMAL RESISTANCE

Symbol Parameter		Conditions		Limits			Unit
Symbol	Falametei	Conditions		Min.	Тур.	Max.	Oilit
R <sub>th(j-c)Q</sub>	Thermal Resistance	Junction to case, IGBT (per 1 element)	(Note.1)	-	-	0.05	
R <sub>th(j-c)D</sub>		Junction to case, FWDi (per 1 element)	(Note.1)	-	-	0.09	K/W
В	Contact Thermal Resistance	Case to heat sink, (per 1 module)		-	0.014	-	IVVV
R <sub>th(c-s)</sub>	Contact Thermal Resistance	Thermal grease applied	(Note.1)				

Note1: If you use this value, R<sub>th(s-a)</sub> should be measured just under the chips.



# **ELECTRICAL CHARACTERISTICS** (Tj = 25°C, unless otherwise noted) **INVERTER PART**

Symbol	bol Parameter Conditions				Limits		Unit
Symbol	Falametel	Conditions	Conditions		Тур.	Max.	Offic
V <sub>CEsat</sub>	Collector-Emitter Saturation	V <sub>D</sub> =15V, I <sub>C</sub> =800A	T <sub>j</sub> =25°C	-	1.85	2.35	V
V CEsat	Voltage	V <sub>CIN</sub> =0V, Pulsed (Fig. 1)	T <sub>j</sub> =125°C	-	1.85	2.35	V
V <sub>EC</sub>	Emitter-Collector Voltage	I <sub>E</sub> =800A, V <sub>D</sub> =15V, V <sub>CIN</sub> = 15V	I <sub>E</sub> =800A, V <sub>D</sub> =15V, V <sub>CIN</sub> = 15V (Fig. 2)		1.7	2.8	V
ton		V <sub>D</sub> =15V, V <sub>CIN</sub> =0V↔15V		0.3	0.8	2.0	
t <sub>rr</sub>		$V_{DC}=15V$ , $V_{CIN}=0V \longleftrightarrow 15V$ $V_{CC}=300V$ , $I_{C}=800A$		-	0.25	0.8	
t <sub>c(on)</sub>	Switching Time	T <sub>i</sub> =125°C		-	0.4	1.0	μS
t <sub>off</sub>		Inductive Load	(Fig. 3,4)	-	1.4	2.3	
$t_{\text{c(off)}}$		mudelive Load	(i ig. 0,+)	-	0.3	1.0	
1	Collector-Emitter Cut-off	V=V V-=15V (Fig. 5)	T <sub>j</sub> =25°C	-	-	1	mA
I <sub>CES</sub>	Current $V_{CE}=V_{CES}, V_{D}=15V, V_{CIN}=15V$ (Fig.		T <sub>j</sub> =125°C	-	-	10	IIIA

#### **CONTROL PART**

Symbol	Parameter	Conditions			Limits		Unit	
Symbol	Falametei	Conditions	Conditions		Тур.	Max.	Jan 1	
	Circuit Current		V <sub>P1</sub> -V <sub>PC</sub>	-	2	4	mA	
I <sub>D</sub>	Circuit Current	V <sub>D</sub> =15V, V <sub>CIN</sub> =15V	V <sub>N1</sub> -V <sub>NC</sub>	-	2	4	IIIA	
$V_{\text{th(ON)}}$	Input ON Threshold Voltage	Applied between : $C_{\text{Pl}}$ - $V_{\text{PC}}$ , $C_{\text{Nl}}$ - $V_{\text{NC}}$		1.2	1.5	1.8	V	
V <sub>th(OFF)</sub>	Input OFF Threshold Voltage			1.7	2.0	2.3		
sc	Short Circuit Trip Level	-20≤T <sub>j</sub> ≤125°C, V <sub>D</sub> =15V	(Fig. 3, 6)	1200	-	-	Α	
	Short Circuit Current Delay	V <sub>D</sub> =15V	(Fig. 2, 6)		0.2			
$t_{ m off(SC)}$	Time	V <sub>D</sub> =15V (Fig. 3, 6)		ı	0.2	1	μS	
ОТ	Over Temperature Protection	Detect Temperature of IGBT chip	Trip level	135	-	-	°C	
OT <sub>(hys)</sub>	Over Temperature Protection	Detect Temperature of 1051 Chip	Hysteresis	ı	20	ı	C	
UVt	Supply Circuit Under-Voltage	-20≤Tj≤125°C	Trip level	11.5	12.0	12.5	V	
UV <sub>r</sub>	Protection	-2051j5125 C	Reset level	-	12.5	-	V	
I <sub>FO(H)</sub>	Fault Output Current		(Note 2)	-	-	0.01	mA	
I <sub>FO(L)</sub>	raun Output Current	$V_D=15V$ , $V_{FO}=15V$ (Note.2)		-	10	15	IIIA	
t <sub>FO</sub>	Fault Output Pulse Width	V <sub>D</sub> =15V (Note.2)		1.0	1.8	1	ms	

Note.2: Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

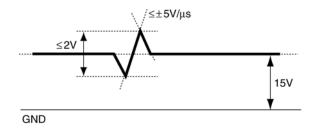
#### **MECHANICAL RATINGS AND CHARACTERISTICS**

Symbol	Parameter	Conditions		Limits		
Symbol Parameter		Conditions		Тур.	Max.	Unit
Ms	Mounting Torque	Mounting part screw : N	6 3.92	4.9	5.88	N•m
$M_{t}$	Mounting Torque	Main terminal part screw : N	8 8.83	9.81	10.8	IN-III
m	Weight	-	-	720	-	g

#### RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V <sub>CC</sub>	Supply Voltage	Applied across C1-E2 terminals	≤ 400	٧
V <sub>D</sub>	Control Supply Voltage	Applied between : $V_{P1}$ - $V_{PC}$ , $V_{N1}$ - $V_{NC}$ (Note.3)	15.0±1.5	٧
V <sub>CIN(ON)</sub>	Input ON Voltage	Applied between : C <sub>PI</sub> -V <sub>PC</sub> , C <sub>NI</sub> -V <sub>NC</sub>	≤ 0.8	· V
V <sub>CIN(OFF)</sub>	Input OFF Voltage		≥ 4.0	V
$f_{PWM}$	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t <sub>dead</sub>	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig. 7)	≥ 3.0	μs

Note3: With ripple satisfying the following conditions: dv/dt swing  $\leq \pm 5V/\mu s$ , Variation  $\leq 2V$  peak to peak



#### PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (V<sub>D</sub>), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
  - After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V<sub>CES</sub> rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)

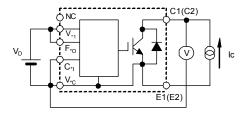


Fig. 1 V<sub>CEsat</sub> Test

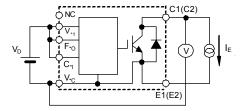


Fig. 2 V<sub>EC</sub> Test

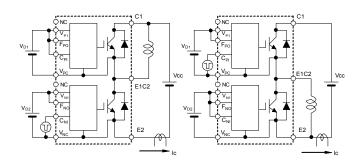


Fig. 3 Switching time and SC test circuit

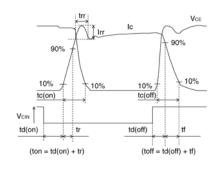


Fig. 4 Switching time test waveform

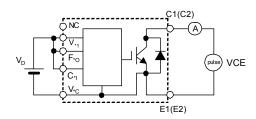


Fig. 5 I<sub>CES</sub> Test

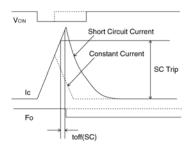
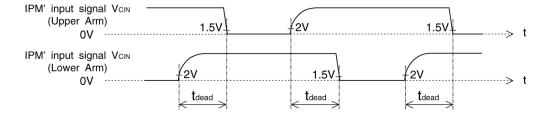


Fig. 6 SC test waveform



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value

Fig. 7 Dead time measurement point example

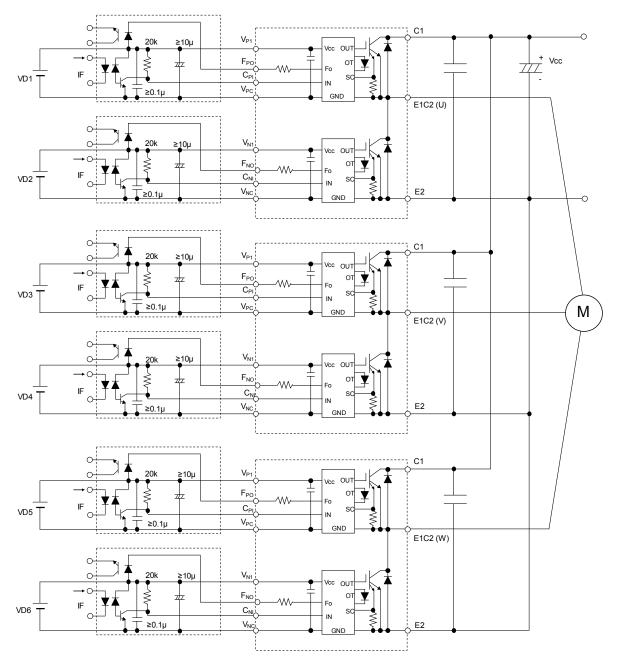
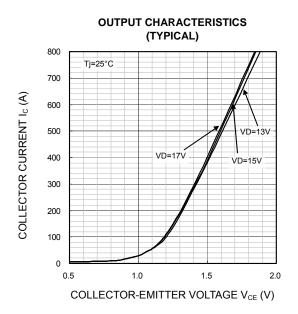


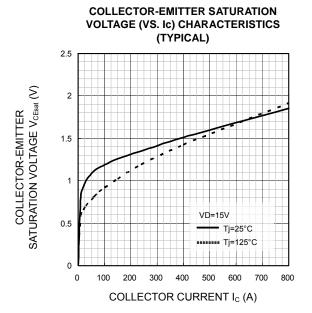
Fig. 8 Application Example Circuit

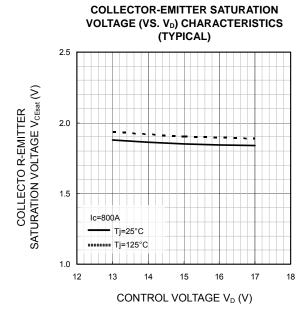
#### NOTES FOR STABLE AND SAFE OPERATION;

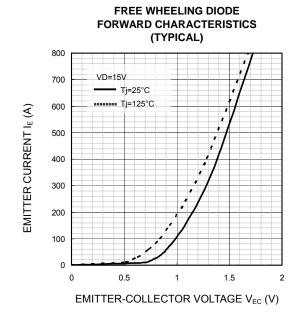
- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- · Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t<sub>PLH</sub>, t<sub>PHL</sub> ≤ 0.8µs, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 6 isolated control power supplies (V<sub>D</sub>). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between C1 and E2 terminal.

#### **PERFORMANCE CURVES**

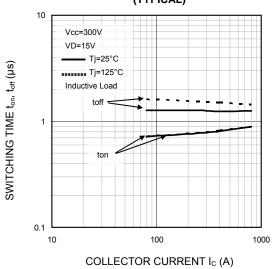




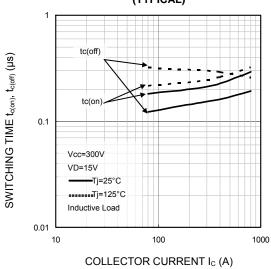




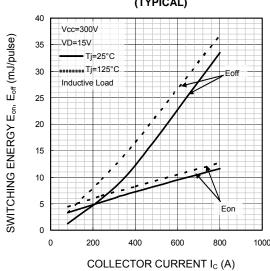




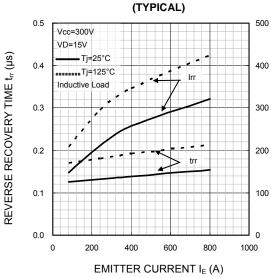
## SWITCHING TIME ( $t_{c(on)}, t_{c(off)}$ ) CHARACTERISTICS (TYPICAL)



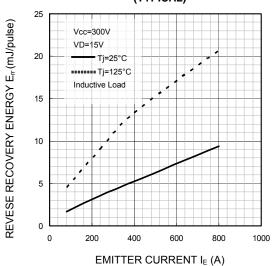
# SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



# FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS

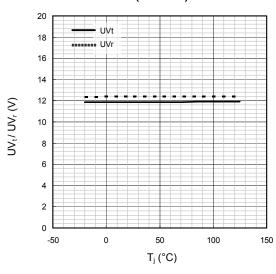


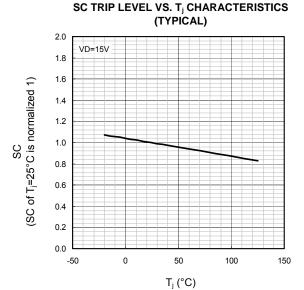
FREE WHEELING DIODE
REVERSE RECOVERY ENERGY CHARACTERISTICS
(TYPICAL)



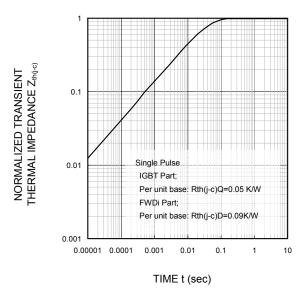
ID VS. fc CHARACTERISTICS (TYPICAL) 80 VD=15V 70 Tj=25°C ••••• Tj=125°C 60 50 I<sub>D</sub> (mA) 40 30 20 10 0 0 5 10 25 f<sub>c</sub> (kHz)

UV TRIP LEVEL VS.  $T_j$  CHARACTERISTICS (TYPICAL)





# TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



# <Intelligent Power Module > PM800DV1B060 FLAT-BASE TYPE INSULATED PACKAGE

## Main Revision for this Edition

No.	Date	Revision		
		Pages	Points	
1	November 2011	8	Output characteristics , "VD=13V" and "VD=17V" were reversed.	

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